TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSIII)

TPC6004

Notebook PC Applications Portable Equipment Applications

- Low drain-source ON resistance: RDS (ON) = 19 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 11 \text{ S (typ.)}$
- Low leakage current: $IDSS = 10 \mu A (max) (VDS = 20 V)$
- Enhancement mode: V_{th} = 0.5 to 1.2 V (V_{DS} = 10 V, I_{D} = 200 μA)

Maximum Ratings (Ta = 25°C)

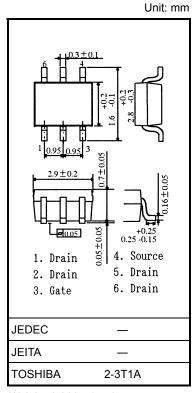
| Characteristics | | Symbol | Rating | Unit | |
|--|------------------------|------------------|------------|------|--|
| Drain-source voltage | | V_{DSS} | 20 | V | |
| Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$) | | V _{DGR} | 20 | V | |
| Gate-source voltage | | V _{GSS} | ±12 | V | |
| Drain current | DC (Note 1) | I _D | 6 | A | |
| | Pulse (Note 1) | I _{DP} | 24 | | |
| Drain power dissipation | (t = 5 s) (Note 2a) | P_{D} | 2.2 | W | |
| Drain power dissipation | (t = 5 s) (Note 2b) | P_{D} | 0.7 | W | |
| Single pulse avalanche energy (Note 3) | | E _{AS} | 5.8 | mJ | |
| Avalanche current | I _{AR} | 3 | Α | | |
| Repetitive avalanche energy (Note 4) | | E _{AR} | 0.22 | mJ | |
| Channel temperature | T _{ch} | 150 | °C | | |
| Storage temperature range | | T _{stg} | -55 to 150 | °C | |

Thermal Characteristics

| Characteristics | Symbol | Max | Unit |
|--|------------------------|-------|------|
| Thermal resistance, channel to ambient (t = 5 s) (Note 2a) | R _{th (ch-a)} | 56.8 | °C/W |
| Thermal resistance, channel to ambient (t = 5 s) (Note 2b) | R _{th (ch-a)} | 178.5 | °C/W |

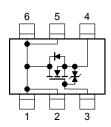
Note: Note 1, Note 2, Note 3, Note 4 and Note 5: See the next page.

This transistor is an electrostatic-sensitive device. Please handle with caution.

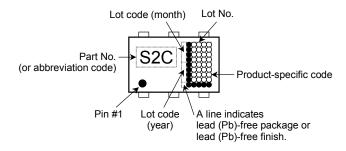


Weight: 0.011 g (typ.)

Circuit Configuration



Marking (Note 5)



Electrical Characteristics (Ta = 25°C)

| Cha | aracteristics | Symbol | Test Condition | Min | Тур. | Max | Unit | |
|---|----------------------|---|---|-----|------|-----|------|--|
| Gate leakage cur | rent | I _{GSS} | $V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$ | _ | _ | ±10 | μΑ | |
| Drain cut-OFF cu | ırrent | I _{DSS} | $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$ | | _ | 10 | μΑ | |
| Drain-source breakdown voltage | | V (BR) DSS | $I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$ | 20 | _ | _ | V | |
| | | V (BR) DSX | $I_D = 10 \text{ mA}, V_{GS} = -12 \text{ V}$ | 8 | _ | _ | v | |
| Gate threshold vo | oltage | V _{th} | $V_{DS} = 10 \ V, \ I_D = 200 \ \mu A$ | 0.5 | _ | 1.2 | V | |
| | | | $V_{GS} = 2.0 \text{ V}, I_D = 3 \text{ A}$ | | 30 | 37 | mΩ | |
| Drain-source ON resistance | R _{DS (ON)} | V _{GS} = 2.5 V, I _D = 3 A | _ | 25 | 32 | | | |
| | | | V _{GS} = 4.5 V, I _D = 3 A | _ | 19 | 24 | | |
| Forward transfer | admittance | Y _{fs} | $V_{DS} = 10 \text{ V}, I_{D} = 3 \text{ A}$ | 5.5 | 11 | _ | S | |
| Input capacitance Reverse transfer capacitance | | C _{iss} | V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz | _ | 1400 | _ | pF | |
| | | C _{rss} | | _ | 165 | _ | | |
| Output capacitance | | C _{oss} | | _ | 180 | _ | | |
| Switching time | Rise time | t _r | ACS 2 A D D = 3 Y | _ | 5 | _ | ns | |
| | Turn-ON time | t _{on} | | _ | 10 | _ | | |
| | Fall time | t _f | | _ | 14 | _ | | |
| | Turn-OFF time | t _{off} | $V_{DD} \simeq 10 \text{ V}$ Duty \leq 1%, $t_W = 10 \mu\text{s}$ | _ | 60 | _ | | |
| Total gate charge (gate-source plus gate-drain) | | Qg | | _ | 17 | _ | nC | |
| Gate-source charge | | Q _{gs} | $V_{DD} \simeq 16 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 6 \text{ A}$ | | 13 | | | |
| Gate-drain ("miller") charge | | Q _{gd} | | _ | 4 | _ | | |

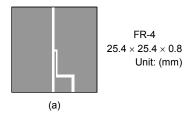
Source-Drain Ratings and Characteristics (Ta = 25°C)

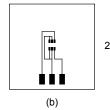
| Characteristics | | Symbol | Test Condition | Min | Тур. | Max | Unit |
|---------------------------------|------|------------------|--|-----|------|------|------|
| Pulse drain reverse current (No | e 1) | I _{DRP} | _ | _ | _ | 24 | Α |
| Forward voltage (Diode) | | V _{DSF} | I _{DR} = 6 A, V _{GS} = 0 V | _ | _ | -1.2 | V |

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)



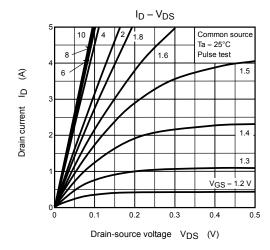


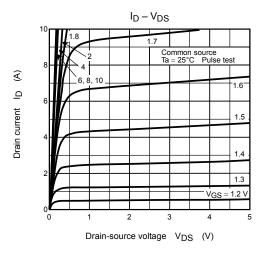
 $\begin{aligned} & \text{FR-4} \\ 25.4 \times 25.4 \times 0.8 \\ & \text{Unit: (mm)} \end{aligned}$

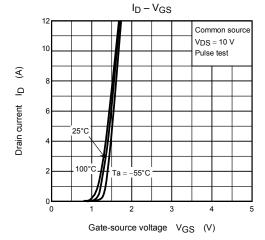
Note 3: V_{DD} = 16 V, T_{ch} = 25°C (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = 3.0 A

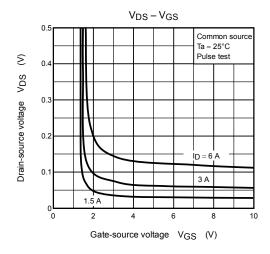
Note 4: Repetitive rating: pulse width limited by maximum channel temperature

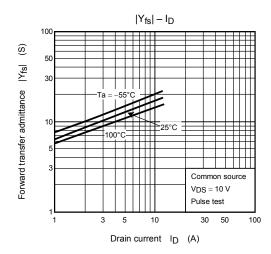
Note 5: • on lower left of the marking indicates Pin 1.

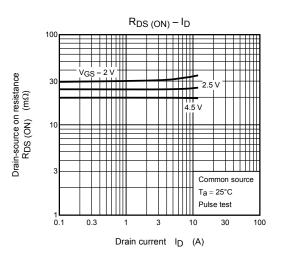


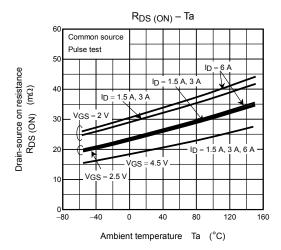


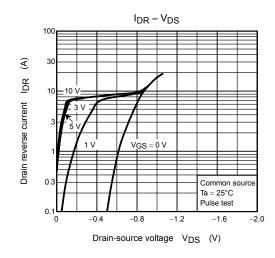


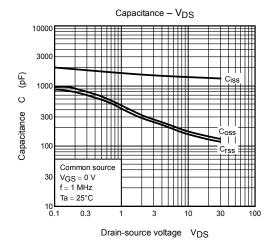


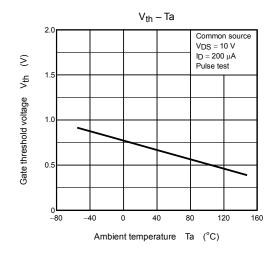


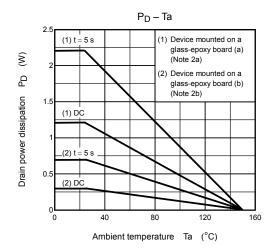


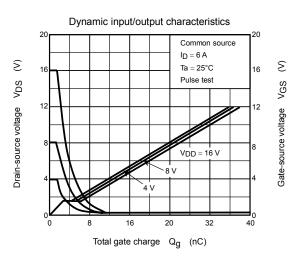


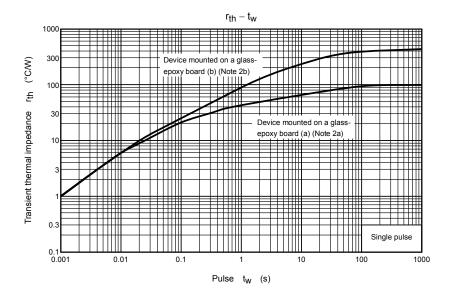


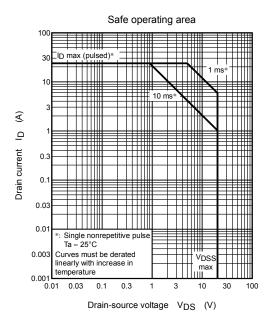












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